

Notice of References Cited	Application/Control No. 10/723,595		Applicant(s)/Patent Under Reexamination WANЕК ET AL.	
	Examiner Thomas P. Noland		Art Unit 2856	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-1,011,990 A	12-1911	Molmark	269/55 X
*	B	US-1,291,610 A	01-1919	Nicoson	269/55 X
*	C	US-2,664,544 A	12-1953	CAPLIS GEORGE W	324/414
*	D	US-3,564,408 A	02-1971	Schulz et al	324/754
*	E	US-3,656,058 A	04-1972	Leathers, Claude L.	324/760
*	F	US-5,003,254 A	03-1991	Hunt et al.	269/903 X
*	G	US-5,364,472 A	11-1994	Heyns et al.	134/7
*	H	US-5,485,759 A	01-1996	Goff et al.	73/865.9
*	I	US-5,641,917 A	06-1997	Hurite et al.	73/865.6 X
*	J	US-5,739,411 A	04-1998	Lee et al.	73/12.13
*	K	US-5,986,753 A	11-1999	Seelig et al.	356/244
*	L	US-2003/0175098 A	09-2003	Koh et al.	414/222.06
*	M	US-2005/0225338 A	10-2005	Sands et al.	324/754

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB 2332633 B	09-2001	United Kingdom	DUNNE et al.	G01R 31/02
	O	WO 01/09627 A2	02-2001	PCT	Wanek et al	G01R 31/00
	P	WO 02/087211 A2	10-2002	PCT	Wanek et al	---
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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